

## CASCADABLE BROADBAND GaAs MMIC AMPLIFIER DC TO 12GHz

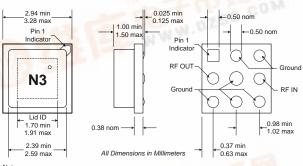
## RoHS Compliant & Pb-Free Product

## Typical Applications

- Narrow and Broadband Commercial and Military Radio Designs
- Linear and Saturated Amplifiers
- Gain Stage or Driver Amplifiers for MWRadio/Optical Designs (PTP/PMP/ LMDS/UNII/VSAT/WLAN/Cellular/DWDM)

## **Product Description**

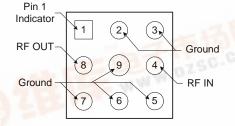
The NBB-302 cascadable broadband InGaP/GaAs MMIC amplifier is a low-cost, high-performance solution for general purpose RF and microwave amplification needs. This  $50\Omega$  gain block is based on a reliable HBT proprietary MMIC design, providing unsurpassed performance for small-signal applications. Designed with an external bias resistor, the NBB-302 provides flexibility and stability. The NBB-302 is packaged in a low-cost, surface-mount ceramic package, providing ease of assembly for highvolume tape-and-reel requirements. It is available in either packaged or chip (NBB-300-D) form, where its gold metallization is ideal for hybrid circuit designs.



- pads are coplanar to within ±0.025 mn
- Lid will be centered relative to frontside metallization with a tolerance of ±0.13 mm.
   Mark to include two characters and dot to reference pin 1.

#### **Optimum Technology Matching® Applied**

☐ Si BJT GaAs HBT GaAs MESFET Si Bi-CMOS SiGe HBT Si CMOS ☐ SiGe Bi-CMOS **√** InGaP/HBT GaN HEMT



#### Package Style: MPGA, Bowtie, 3x3, Ceramic

#### **Features**

- Reliable, Low-Cost HBT Design
- 12.0dB Gain, +13.7dBm P1dB@2GHz
- High P1dB of +14.0dBm @ 6.0GHz and
  - +11.0dBm@14.0GHz
- Single Power Supply Operation
- 50Ω I/O Matched for High Freq. Use

#### Ordering Information

NBB-302 Cascadable Broadband GaAs MMIC Amplifier DC to

12GHz

NBB-302-T1 or -T3Tape & Reel, 1000 or 3000 Pieces (respectively)

NBB-302-E Fully Assembled Evaluation Board

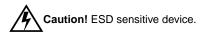
Extended Frequency InGaP Amp Designer's Tool Kit nc. Tel (336) 664 1233 NBB-X-K1 RF Micro Devices, Inc. 7628 Thorndike Road Fax (336) 664 0454 Greensboro, NC 27409, USA http://www.rfmd.com

Functional Block Diagram

## **Absolute Maximum Ratings**

Parameter	Rating	Unit
RF Input Power	+20	dBm
Power Dissipation	300	mW
Device Current	70	mA
Channel Temperature	200	°C
Operating Temperature	-45 to +85	°C
Storage Temperature	-65 to +150	°C

Exceeding any one or a combination of these limits may cause permanent damage.



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Parameter	Specification			Unit	Condition	
Parameter	Min.	Тур.	Max.	Unit	Condition	
Overall					$V_D = +3.9 \text{ V}, I_{CC} = 50 \text{ mA}, Z_0 = 50 \Omega, T_A = +25 ^{\circ}\text{C}$	
Small Signal Power Gain, S21	12.0	13.5		dB	f=0.1GHz to 1.0GHz	
	11.0	13.0		dB	f=1.0GHz to 4.0GHz	
		12.5		dB	f=4.0GHz to 6.0GHz	
	9.0	10.5		dB	f=6.0GHz to 12.0GHz	
		9.5 (avg.)		dB	f=12.0GHz to 14.0GHz	
Gain Flatness, GF		±0.6		dB	f=0.1GHz to 8.0GHz	
Input and Output VSWR		2.4:1			f=0.1GHz to 4.0GHz	
·		2.0:1			f=4.0GHz to 12.0GHz	
		2.8:1			f=12.0GHz to 15.0GHz	
Bandwidth, BW		12.5		GHz	BW3 (3dB)	
Output Power @						
-1dB Compression, P1dB		13.7		dBm	f=2.0GHz	
		14.8		dBm	f=6.0GHz	
		11.0		dBm	f=14.0GHz	
Noise Figure, NF		5.5		dB	f=3.0GHz	
Third Order Intercept, IP3		+23.5		dBm	f=2.0GHz	
Reverse Isolation, S12		-15		dB	f=0.1 GHz to 12.0 GHz	
Device Voltage, V <sub>D</sub>	3.6	3.9	4.2	V		
Gain Temperature Coefficient, $\delta G_T/\delta T$		-0.0015		dB/°C		
MTTF versus Temperature						
@ I <sub>CC</sub> =50mA						
Case Temperature		85		°C		
Junction Temperature		122.9		°C		
MTTF		>1,000,000		hours		
Thermal Resistance						
$\theta$ JC		194		°C/W	$\frac{J_T - T_{CASE}}{V_D \cdot I_{CC}} = \theta_{JC}(^{\circ}C/Watt)$	

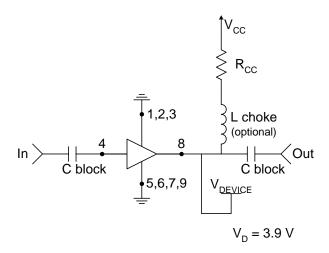
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Pin	Function	Description	Interface Schematic	
1	GND	Ground connection. For best performance, keep traces physically short and connect immediately to ground plane.		
2	GND	Same as pin 1.		
3	GND	Same as pin 1.		
4	RF IN	RF input pin. This pin is NOT internally DC blocked. A DC blocking capacitor, suitable for the frequency of operation, should be used in most applications. DC coupling of the input is not allowed, because this will override the internal feedback loop and cause temperature instability.		
5	GND	Same as pin 1.		
6	GND	Same as pin 1.		
7	GND	Same as pin 1.		
8	RF OUT	RF output and bias pin. Biasing is accomplished with an external series resistor and choke inductor to $V_{CC}.$ The resistor is selected to set the DC current into this pin to a desired level. The resistor value is determined by the following equation: $R = \frac{(V_{CC} - V_{DEVICE})}{I_{CC}}$ Care should also be taken in the resistor selection to ensure that the current into the part never exceeds maximum datasheet operating current over the planned operating temperature. This means that a resistor between the supply and this pin is always required, even if a supply near 5.0V is available, to provide DC feedback to prevent thermal runaway. Alternatively, a constant current supply circuit may be implemented. Because DC is present on this pin, a DC blocking capacitor, suitable for the frequency of operation, should be used in most applications. The supply side of the bias network should also be well bypassed.	RF IN O	
9	GND	Same as pin 1.		

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## **Typical Bias Configuration**

Application notes related to biasing circuit, device footprint, and thermal considerations are available on request.



Recommended Bias Resistor Values						
Supply Voltage, V <sub>CC</sub> (V)	5	8	10	12	15	20
Bias Resistor, R <sub>CC</sub> (Ω)	22	81	122	162	222	322

## **Application Notes**

#### Die Attach

The die attach process mechanically attaches the die to the circuit substrate. In addition, it electrically connects the ground to the trace on which the chip is mounted, and establishes the thermal path by which heat can leave the chip.

#### Wire Bonding

Electrical connections to the chip are made through wire bonds. Either wedge or ball bonding methods are acceptable practices for wire bonding.

### **Assembly Procedure**

Epoxy or eutectic die attach are both acceptable attachment methods. Top and bottom metallization are gold. Conductive silver-filled epoxies are recommended. This procedure involves the use of epoxy to form a joint between the backside gold of the chip and the metallized area of the substrate. A 150°C cure for 1 hour is necessary. Recommended epoxy is Ablebond 84-1LMI from Ablestik.

#### **Bonding Temperature (Wedge or Ball)**

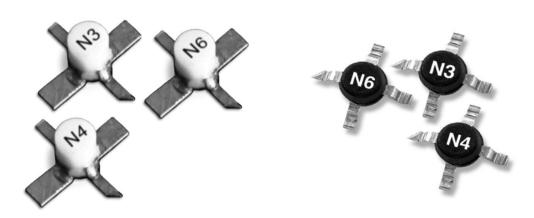
It is recommended that the heater block temperature be set to  $160^{\circ}C \pm 10^{\circ}C$ .

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# Extended Frequency InGaP Amplifier Designer's Tool Kit NBB-X-K1

This tool kit was created to assist in the design-in of the RFMD NBB- and NLB-series InGap HBT gain block amplifiers. Each tool kit contains the following.

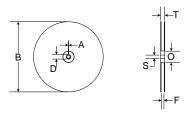
- 5 each NBB-300, NBB-310 and NBB-400 Ceramic Micro-X Amplifiers
- 5 each NLB-300, NLB-310 and NLB-400 Plastic Micro-X Amplifiers
- 2 Broadband Evaluation Boards and High Frequency SMA Connectors
- Broadband Bias Instructions and Specification Summary Index for ease of operation



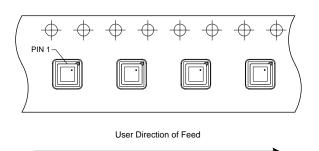
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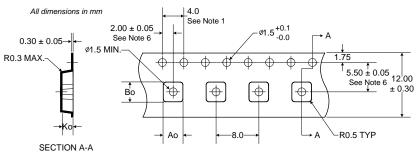
## **Tape and Reel Dimensions**

All Dimensions in Millimeters



330 mm (13") REEL			Micro-X, MPGA		
	ITEMS	SYMBOL	SIZE (mm)	SIZE (inches)	
FLANGE	Diameter	В	330 +0.25/-4.0	13.0 +0.079/-0.158	
	Thickness	Т	18.4 MAX	0.724 MAX	
	Space Between Flange	F	12.4 +2.0	0.488 +0.08	
нив	Outer Diameter	0	102.0 REF	4.0 REF	
	Spindle Hole Diameter	S	13.0 +0.5/-0.2	0.512 +0.020/-0.008	
	Key Slit Width	Α	1.5 MIN	0.059 MIN	
	Key Slit Diameter	D	20.2 MIN	0.795 MIN	





Ao = 3.6 MM Bo = 3.6 MM Ko = 1.7 MM

#### NOTES:

- 1. 10 sprocket hole pitch cumulative tolerance ±0.2.

- 2. Camber not to exceed 1 mm in 100 mm.

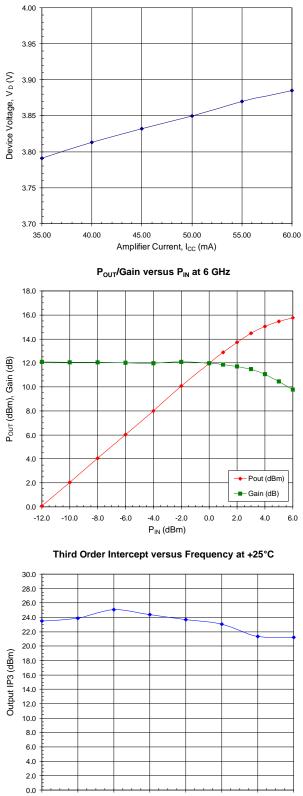
  3. Material: PS+C

  4. Ao and Bo measured on a plane 0.3 mm above the bottom of the pocket.

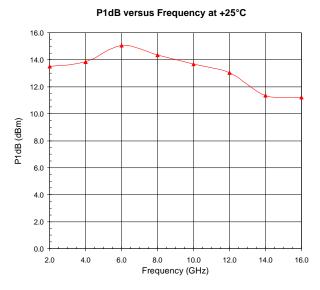
  5. Ko measured from a plane on the inside bottom of the pocket to the surface of the carrier.

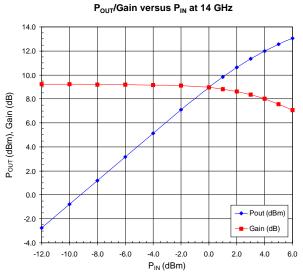
  6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

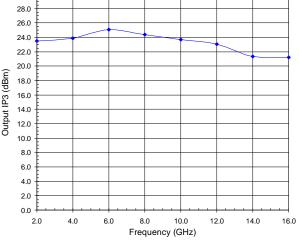
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**Device Voltage versus Amplifier Current** 



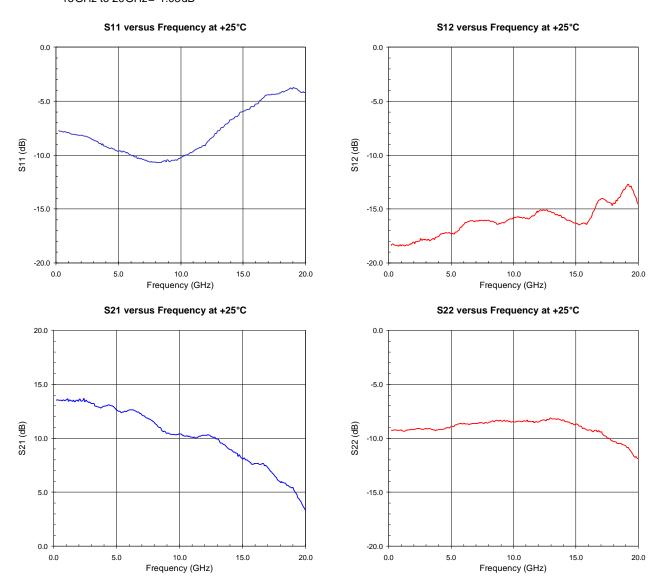




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Note: The s-parameter gain results shown below include device performance as well as evaluation board and connector loss variations. The insertion losses of the evaluation board and connectors are as follows:

1 GHz to 4 GHz=-0.06 dB 5 GHz to 9 GHz=-0.22 dB 10 GHz to 14 GHz=-0.50 dB 15 GHz to 20 GHz=-1.08 dB



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